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GENERAL ASPECTS OF TRACE ANALYTICAL METHODS — V

COMPARISON OF THE ABILITIES OF TRACE ANALYTICAL METHODS TO DETERMINE SMALL AMOUNTS OR CONCENTRATIONS OF ELEMENTS

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GENERAL ASPECTS OF TRACE ANALYTICAL METHODS - V COMPARISON OF THE ABILITIES OF TRACE ANALYTICAL METHODS TO DETERMINE SMALL AMOUNTS OR CONCENTRATIONS OF ELEMENTS

<u>Abstract</u>. The report compares realistic "limits of determination" defined as $10 [s_{bl}]$, where $[s_{bl}]$ is the standard deviation of the blank, for most elements determined by the more common analytical techniques. Whilst recognising the necessarily approximate and transient nature of the data, it is believed that it will provide a valuable comparison of the capabilities of the techniques considered at the present time.

For many years representatives of the Analytical and Applied Chemistry Divisions have discussed the idea of collecting and tabulating data concerning effectiveness of the most important trace analytical methods for the determination of small amounts or concentrations of elements. In compiling this report the Commission on Microchemical Techniques and Trace Analysis recognizes the reservations which have always to be expressed if various analytical methods, many of them in a state of rapid development, are to be compared in this way. Therefore, this project can only be an attempt to give a temporary and approximate representation.

The ability of analytical methods to detect small amounts or concentrations is best expressed by the statistical term "limit of detection", which Kaiser (Ref.1) has defined as:

$$\underline{x} = \overline{x}_{b1} + k \cdot |s_{b1}|$$
 with $\underline{c} = f(\underline{x})$

In these equations, which are accepted by IUPAC (Ref. 1a), \underline{x} is the smallest acceptable measureable signal and \underline{c} the lowest concentration which can be measured by the analytical procedure, and k is a constant. To calculate \underline{x} the standard deviation s_{b1} and the mean value \overline{x}_{b1} of the blank are determined from at least 20 blank analyses. For this, all steps of the complex analytical procedure with their own contributions to the blank must be taken into account, including all reagents and vessels needed, all manipulations, and the electronic noise of the equipment. The factor k depends on the desired or required confidence; by convention k = 3 is mostly used, while k = 6 defines the guarantee of purity according to Kaiser (Ref.1).

Values of <u>x</u> or <u>c</u> for a given analytical method are only valid in connection with the complete working instruction; each variation of one of the steps of an analytical procedure will lead to some change in the values of <u>x</u> and <u>c</u>. Nevertheless, an examination of the literature shows that tabulated <u>x</u>-values often are calculated from analytical results which have been obtained using highly optimized working conditions or even from idealized model analyses; frequently the value of the factor k is not given.

Additionally, there is often a lack of consideration of the numerous possibilities for systematic errors whose sources and magnitude also change with changes in sample material and analytical conditions. So tables of original data taken from publications, each of which describes the application of a special analytical method to a special analytical problem are mostly of little practical use.

Detection limit data for a method, without information about the sample, its pretreatment and all the details of the analytical procedure, at best can give only a very rough impression of the ability of the method to detect some selected elements or compounds. In consideration of this viewpoint, some simplifying assumptions seemed to be necessary in the present report with regard to a useful comparison and even to a reasonable evaluation of such data for various analytical methods.

1. Instead of the above "limit of detection":

$$x = x_{b1} + k \cdot |s_{b1}| \quad (k = 3)$$

a "limit of determination" L₀ was defined using k = 10 in the above formula (Ref. 1b,2). It was used to compile the capabilities of analytical methods in the following tables. These data are normally based only on the second part of the above equation: $10 \cdot |s_{bl}|$ under the following provisions (see items 2 and 3); exceptions are the data for spectrophotometric methods and for atomic absorption spectrometry whose calculation bases are explained below. In contrast to the factors k = 3 or k = 6 which are well defined from theoretical aspects, the factor k = 10 may be a more practical one, which allows a better consideration of the

uncertainty when the abilities of analytical methods in extreme trace analysis are compared. We also have to remember that the factor k = 10, like the factors k = 3 or k = 6, is based on a "normal Gaussian distribution" in spite of the fact that the results in trace analysis approach zero, which means that "non-Gaussian distribution" will frequently prevail. To overcome the problem of inhomogeneous dimensions of literature data which are presented in absolute quantities (g-scale) or concentrations (g ml⁻¹ scale) the same symbol LQ will be used in both cases. Therefore, this compilation should be only considered as a first attempt which needs a lot of further discussions and efforts to find a more satisfying solution.

2. The compiled data refer to the determination of elements in pure aqueous solutions which contain only the element in question. They are obtained by averaging literature data. Any combination of the methods of determination dealt with in this survey with special pretreatment techniques such as decomposition or preconcentration, as well as with micro techniques, are omitted. The only exception as regards the combination of preconcentration and determination is anodic and cathodic stripping voltammetry on account of its character, as mentioned at the end of the report.

3. The report is restricted to some of the most important analytical methods of general applicability used in trace analysis. The compiled data were obtained by the use of commercially available instruments and recommended analytical procedures from the literature. Because of this simplification of the procedure of data compilation, any application of the data as standard values in practical trace analysis must be subject to some restrictions. The data are a measure of the effectiveness of analytical methods with regard to the determination of amounts or concentrations of elements that are as small as possible. However, in trace analysis generalization from one analytical problem to another is not allowed because each different sample material may result in a completely new analytical situation leading to very different statistical and systematic errors, and changing the detection limit. Similarly considerable flexibility exists in the operational conditions under which many of the analytical techniques can be applied. Although literature data have been critically evaluated based on the present state of knowledge, the tabulated values can only re-present approximations of the "true" limits of determination which are valid for each special analytical problem. Depending on the conditions the possibility of a variation of L_0 -values (10 \cdot sb]) over a range of one order of magnitude or more must be taken into account. Any generalization should be treated with caution. Nevertheless, the data compiled in this report may be usefully used as an initial survey of the effectiveness of different analytical methods regarding the determination of small quan-

tities of elements. Moreover, critically applied, they may be helpful in selecting the most sensitive method for solving a non-routine trace analytical problem. The limits of determination for a wide range of elements and techniques are compiled below in connection with the following considerations.

1. Molecular absorption spectrometry (Table. 1)

The values correspond to an absorbance of 0.025 for an absorption path length of 1 cm and an assumed absorbance error of \pm 0.0025 assuming a sample consumption of 1 ml.

2. Atomic absorption spectrometry (AAS)(Table 1)

(a) Flame AAS. The values correspond to an absorbance of 0.005 and assume an absorbance $error of \pm 0.0005$, using conventional burners with a 10 cm-absorption path length and a sample consumption of 1 ml. Other burner typs or special fuel/Oxidant gas combinations are indicated by footnotes. New special techniques (e.g. μ l-injection or Pt-loop), which can give an increase in sensitivity by a factor of 10-100 will not be considered.

(b) Electrothermal AAS. The values correspond to an absorbance of 0.025 and assume an absorbance error of ± 0.0025 on the basis of a consumed sample volume of 50 μ l. All data were obtained with the Perkin-Elmer HGA-74 graphite furnace with the exception of Hg which was determined by the cold vapour technique.

3. Atomic fluorescence spectrometry (Table 1) The data assume a sample consumption of 1 ml.

4. <u>Emission spectrograhy (Table 2)</u> A sample consumption of 0.1 ml is assumed. Only values corresponding to photographic recording have been mentioned because spectrometric detection which is mainly used in routine analysis depends much more on apparatus parameters and is mostly less sensitive. (a) <u>Direct current arc</u>. In general a 10-15 A arc (occasionally 20-25 A) was employed as excitation source.

(b) <u>Copper and graphite spark</u>. A condensed spark of 10-20 kV with optimal inductivity to capacity relation was generally employed as excitation source.

5. Emission spectrometry (Table 2)

The data assume a sample consumption of 1 ml.

(a) Inductively coupled plasma (ICP) spectrometry. In general a 27 MHz 1-3 kW generator with

Table 1. ${\rm L}_{\rm Q}$ values of some analytical methods (Ref. 1a,2)

Element	Molecular absorption spectrophotometry 3)a	Atomic absorption spe flame ^{b)} electi		ectrometry ⁴⁾ rothermal ^{C)}	Atomic fluorescence dy spectrometry dy	
	μ g m] ⁻¹	µg ml ^{−1}	ng	µg m] ⁻¹⁵⁾	µg m] ^{−1}	
Ag	0.1 ⁶⁾ ; 0.05 ⁷⁾	0.07	0.02	0.0004	0.001	
A1	0.01 ^{8,9)}	1 ⁶⁷⁾	0.2	0.004	0.5	
As	$0.05^{10}; 0.1^{11})$	0.2	0.2	0.004	0.8	
Au	0.08 ¹²⁾ ;0.04 ¹³⁾	0.3	0.06	0.001	0.02	
В	0.002 ¹⁴⁾ ; 0.004 ¹⁵)	45	10	0.2		
Ba		0.5 ⁶⁷⁾	0.8	0.02		
Ве	$0.01^{9}; 0.05^{16})$	0.03 ⁶⁷⁾	0.02	0.0004	0.05	
Bi	0.07 ⁶⁾	1	0.2	0.004	0.1	
Ca	0.06^{17}	0.08	0.2	0.003	0.1	
Cd	0.04 ⁶⁾	0.05	0.006	0.0001	0.0001	
Ce	0.2 ¹⁸⁾ ;0.3 ¹⁹⁾				3	
Со	0.05 ²⁰⁾ ;0.04 ²¹⁾	0.2	0.2	0.004	0.05	
Cr	0.04 ²²⁾	0.2	0.1	0.002	0.1	
Cs		0.6			•••	
Cu	0.03 ⁶⁾ ;0.1 ²³⁾	0.2	0.2	0.003	0.005	
Dy	0.2 ¹⁸⁾	0.8 ⁶⁷⁾			2	
Er	0.2 ¹⁸⁾	1 ⁶⁷⁾			3	
Eu	0.2 ¹⁸⁾	0.7 ⁶⁷⁾			0.1	
Fe	0.07 ²⁴⁾ ; 0.1 ²⁵⁾	0.2	0.1	0.002	0.04	
Ga	0.04 ^{12,26)}	3	1	0.02	2	
Gd	0,2 ¹⁸⁾	20 ⁶⁷⁾	-	0.02	L	
Ge	0.01 ²⁷⁾	3 ⁶⁷⁾			0.5	
Hf	0.1 ²⁸⁾	17 ⁶⁷⁾			30	
Hg	0.08 ⁶⁾	15	10:15 ⁶⁹⁾	0.2	0 1	
Но	0,2 ¹⁸⁾	0.8 ⁶⁷⁾	,	012	1	
In	0.04 ⁶⁾	1	0.8	0.02	- 0 5	
Ir	0.1 ²⁹⁾	13	9	0.2	500	
к		0.06	0.05	0.001		
La	0.2 ¹⁸⁾	40 ⁶⁷⁾				
Li		0.05	0.2	0.003		
Lu	D,2 ¹⁸⁾	10 ⁶⁷⁾			15	
Mg	0.04 ³⁰⁾ ;0.1 ³¹⁾	0.01	0.004	0.0008	0.005	
Mn	0.2 ³²⁾ ;0.002 ³³⁾	0.1	0.04	0.0008	0.03	
Мо	0.1 ³⁴⁾ ;0.2 ²⁵⁾	0.8 ⁶⁷⁾	1	0.02	3	
Na		0.02	0.03	0.006	500	
Nb	0.07 ²⁵⁾ ;0.04 ³⁵	3567)		01000	8	
Nd	0.2 ¹⁸⁾	11 ⁶⁷⁾			10	
Ni	0.1 ³⁶⁾ ;0.02 ³⁷⁾	0.2	0.5	0.01	0 1	
Np	0.4 ³⁸⁾			0101	0.1	
Os	0.2 ³⁹⁾	1 ⁶⁷⁾			750	
Р	0.03 ⁴⁰⁾ ;0.003 ³⁴⁾	500 ⁶⁷)			750	
Pb	0.08 ⁶⁾ ; 0.1 ⁴¹⁾	0.6	0.1	0.002	0.05	
Pd	0.02 ⁴²⁾ ;0.04 ⁴³⁾	0.4	2	0.04	0.2	

Table 1. (continued)

 $\rm L_{0}$ values of some analytical methods(Ref. 1a,2)

Element	Molecular absorption	Atomic abso	Atomic fluorescence		
	_1	flame ⁰ /	electro	thermal ^{C)}	spectrometry d)
	µg ml ⁻¹	µg ml ⁻¹	ng ⊢	ig ml ⁻¹⁰⁷	µg m]−1
Pm	0.2 ¹⁸⁾				
Pr	0.2 ¹⁸⁾	25 ⁶⁷⁾	3		5
Pt	0.6 ²⁹⁾	2	3	0.06	2
Rb		0.2			
Re	$0.1^{44}; 0.1^{25}$	17 ⁶⁷⁾			
Rh	0.7 ²⁹)	0.5	10	0.2	15
Ru	$0.3^{45}; 0.1^{19}$	1			3
S	0.01^{46} ; 0.02^{47}				
Sb	0.08^{12} ; 0.1^{48}	1	0.2	0.004	0.3
Sc	$0,2^{49}; 0.02^{59}$	0.5 ⁶⁷⁾			25
Se	0.2^{51} ; 0.08^{52}	0.368)	0.3	0.006	0.5
Si	0.03 ⁵³⁾	5 ⁶⁷⁾	0.5	0.01	3
Sm	0.2 ¹⁸)	10 ⁶⁷)			0.8
Sn	0.07^{27} ; 0.03^{54})	0.468)	0.3	0.006	0.3
Sr		0.267)	0.1	0.002	0.1
Ta	2^{55} ; 0.05 ⁵⁶	3567)			
Тb	0.2 ¹⁸)	867)			5
Tc	0.05^{25} ; 0.2^{34}		500	10	
Te	0.1^{57} ; 0.6^{58}	0.7	1	0.02	0.5
Th	0.2^{18} ; 0.4^{59} ;	67.70			
Ti	$0.1^{00}; 0.03^{25}$	0.367,70) 200	4	30
TI	0.06^{12}	0.6	0.5	0.01	0.05
Tm	0.2^{10}	0.60/)			
U	0.4^{41} ; 0.1^{62}	15067)	0.1	0.002	25
V	0.4^{03} ; 0.04^{04}	267)	2	0.04	1
W	0.2 ³⁴	2067)			
Y	0.1^{05}	20/)			
Yb	0.2^{10}	0.20/)	0.5	0.01	0.05
Zn	$0.02^{0}; 0.02^{00}$	0.02	0.003	0.00006	0.0001
Zr	0.7 ^{20,05)}	100/,/1)			40

Footnotes to Table 1

a) Reference (2)
b) References (2-5)
c) References (2,3,6-8)
d) References (2,9-54)

Footnotes to Table 1 (continued)

1) Compiled by O.G. Koch 2) The values are given in $\mu g m l^{-1}$, i.e. $L_0 [\mu g m l^{-1}]$ unless otherwise stated. $L_0 [\mu g m l^{-1}] = L_0 [\mu g]$ assuming a sample consumtion of 1 ml 3) Per absorption path length of 1 cm 4) Values for air/C2H2-flame, without specifying flame composition 5) For sample aliquot of 50 $_{\rm H}l$ 6) Dithizone 7) 1,10-Phenanthroline brompyrogallol red 8) Eriochrom cyanine9) Chromazurol S10) Molybdenum blue 61) Dibenzoylmethane 11) Silver diethyldithiocarbamate 62) 2(2-pyridylazo)-5-diethylaminophenol 12) Rhodamine B 63) Benzohydroxamic acid 13) Methyl violet 14) Curcumin 64) 3,3'-Dimethylnaphthidine
65) Pyrocatechol violet
66) 1(5-Chloro-2-pyridylazo)-2-naphthol 15) Methylene blue 16) 8-Hydroxyquinaldine 67) N₂O/C₂H₂ flame 17) Glyoxal-bis-(2-hydroxyanil)
18) Arsenazo I
19) 1,10-Phenanthroline 68) Ar/H2 flame 69) 13,5-cm gas path length cell 70) With 5 mg NH_4F ml⁻¹ 71) With 2 mg HN_4F ml⁻¹ 0) Nitroso-R salt 1) 2-Nitroso-1-naphthol 2) Diphenylcarbazide 3) Bathocuproine 4) Bathophenanthroline 5) Thiocyanate 26) Hematein 27) Phenylfluorone 28) Xylenol orange 29) SnC1₂ 30) Eriochrome black T 31) 8-Hydroquinoline 32) Formaldoxime 33) Leucomalachite green 34) Dithiol 35) Brompyrogallol red 36) Dimethyl glyoxime
 37) Pyridine-2-aldehyde-2-quinolylhydrazone 38) Thorin 39) 1-Naphthylamine-4,6,8-trisulphonic acid 40) Molybdenum blue 41) 4(2-Pyridylazo)resorcinol 42) Pyridine Rose bengal extra 43) p-Nitrosodiphenylamine 44) α-Furildioxime 45) 1,4-Diphenylthiosemicarbazide46) Methylene blue-method 47) p-Rosaniline 48) Methylfluorone 49) Alizarin sulphonic acid 50) Eriochrome brilliant violet B 51) 3,3'-Diaminebenzidine 52) 2,3-Diaminonaphthalene 53) Molybdenum blue 54) 3'-pyridylfluorone 55) Pyrogallol 55) Pyrogallon 56) Malachite green 57) Bismuthiol II 58) Tellurium sol 59) Thorin

- 60) Tiron

	Emission	spectrography	/	Emission spectrometry		
Element	direct current arc ^a)	copper sparkb)	graphite spark 2)c)	ICP	Flame ^{e)}	
Ag	0.1	2	0.005	0.02	0.1	
A1	0.5	0.1	0.03	0.01	0.05	
As	20	5	1	0.2	150	
Au	1	0.3		0.1	5	
В	0.5	0.1	0.003	0.01	150	
Ba	0.2	0.1	0.02	0.0005	0.005	
Ве	0.05	0.002		0.0005	3	
Bi	0.3	0.2	0.05	0.3	150	
Ca	0.05	0.1	0.01	0.00005	0.0005	
Cd	2	1	0.2	0.005	10	
Ce	10	0.5		0.02	50	
Со	0.3	0.5	0.05	0.01	0.3	
Cr	0.7	0.1	0.01	0.005	0.03	
Cs	3	0.5			0.5	
Cu	0.05	1	0.005	0.005	0.05	
Dy	3	0.5		0.04	0.5	
Er	2	0.5		0.01	1	
Eu	2	0.03		0.001	0.01	
Fe	2	0.8	0.03	0.02	0.3	
Ga	0.7	0.5		0.03	0.2	
Gd	3	0.3		0.02	20	
Ge	0.5			0.05	3	
Hf	15	0.5		0.1	250	
Hg	20	5	0.1	0.2	50	
Но	2	0.2		0.05	0.5	
In	1	1	0.1	0.2	0.02	
Ir	5	5		0.5	250	
К	5	0.1		0.2	0.01	
La	2	0.05		0.01	20	
Li	0.2	0.002		0.002	0.0002	
Lu	2	0.5		0.05	3	
Mg	0.05	0.01	0.005	0.0005	0.1	
Mn	0.3	0.03	0.003	0.002	0.02	
Mo	2	0.05	0.02	0.01	0.8	
Na	1	0.3		0.001	0.002	
Nb	0.8	0.2	0.05	0.01	5	
Nd	10	0.3		0.02	5	
Ni	0.5	0.1	0.01	0.02	0.1	
Np		2				
0s	4			0.05	30	
Р	30	20	0.1	0.2		
Pa		2				

Table 2. (continued)

 $\rm L_{0}\mbox{-}values~(\mu g~ml^{-1})$ of some analytical methods $^{1)}$

	Emission s	spectrograph	Emission spectrometry			
Element	direct current arc ^{a)}	copper spark ^{b)}	graphite spark ^{2)c)}	ICP	Flame ^{e)}	
Pb	2	0.4	0.02	0.02	0.8	
Pd	5	0.5		0.05	0.3	
Pr	20	0.2		0.1	10	
Pt	3	0.02		0.1	15	
Pu		2				
Rb	10	0.2			0.03	
Re	10	2		0.2	1	
Rh	3			0.02	1	
Ru	10			0.5	2	
Sb	3	5	0.1	0.5	50	
Sc	0.5	0.01		0.01	1	
Se	100			0.2	500	
Si	0.5	0.1		0.03	20	
Sm	5	0.5		0.05	2	
Sn	0.7			0.1	1	
Sr	0.5	0.1	0.02	0.0002	0.001	
Ta	50	1	0.1	0.3	50	
Tb	10	1		0.05	5	
Te	50	3		0.3	500	
Th	10	0.5		0.02	400	
Ti	0.2	0.1	0.03	0.005	1	
TI	3	2	0.5	0.5	0.1	
Tm	3	0.1		0.02	1	
U	25	1		0.1	40	
V	0.5	0.08	0.01	0.02	0.05	
W	7	0.1	0.1	0.02	3	
Ŷ	1	0.05		0.001	5	
Yb	1	0.05	· ·	0.002	0.2	
Zn	3	2	0.1	0.005	150	
Zr	0.5	0.3	0.03	0.01	20	

1) Compiled by O.G. Koch

2) With coated electrodes

a) References (2,50-58, 59-64, 66-72) b) References (2,55,56,73-75) c) References (2,65,76,77) d) References (78-82, 113-122) e) References (2,79,83-88)

		Tab	ole 3. L _o v	alues (µg ml ⁻	^{·1}) of	some ana	lytical me	thods1)	
Ele- ment	XRF (2,a)	Mass spectro- metry (3,4,b)	Neutron without chemical (c)	activation ²⁾ with separation (d)	Ele- ment	XRF (2,a)	Mass spectro- metry (3,4,b)	Neutron a without chemical (c)	activation ²⁾ with separation (d)
Ar Ag Al As Au B Ba	4 5 1 2 1 ⁵)	(0.0003) 0.02 0.002 0.006 0.02 0.001 0.02	(0.0003) 0.0002 0.003 0.002 0.006	3 50 0.004 0.001	Ne Nb Nd Ni Os P	0.5	(0.0002) 0.01 0.04 0.007 (0.0001) 0.04 0.003	(0,02) 0.01 0.05 0.1 0.04 0.2	0.5 0.2 0.2 0.07
Be Bi Br	15) 2 2	0.001 0.02 0.01	5 0.0005	10 0.004	Pb Pd Pr Pt	2	0.03 0.03 0.01 0.05	25 0.002 0.001	50 0.005 0.002
Ca Cd Ce	0.3 0.7 0.6	0.001 0.03 0.01 0.01	0.5 0.03 0.2	10 0.07 0.4	Rb Re Rh	Ľ	0.03 0.01 0.02 0.01	0.0003 0.0003 0.0002	0.07 0.5 0.0006 0.06
Co Cr Cs	0.4 0.1 0.5 0.5	0.004 0.005 0.005 0.01	0.000 0.03 7 0.5 0.005	0.03 0.6 14 1 0.01	S Sb Sc	1; 0.1 ⁵) 0.08	0.003 0.02 0.004 0.01	0.2 300 0.01 0.03	0.05 600 0.02 0.06 0.05
Dy Er Eu	15). 2	0.05 0.05 0.02 0.02	0.0001 0.006 0.00001	0.0002 0.01 0.00003	Se Si Sm Sn	0.2 0.04	0.003 0.05 0.03	0.01 0.2 0.001 0.5 0.2	0.03 0.5 0.002 1
Fe Ga Gd Ge	1	0.002 0.005 0.01 0.05 0.02	0.08 140 0.004 0.01 0.01	280 0.01 0.03 0.02	Ta Tb Te Th	1	0.001 0.02 0.01 0.03 0.02	0.2 0.2 0.03 0.05 0.001	0.4 0.3 0.06 0.1 0.004
H He Hf	0.7	(0.00001) (0.00003) 0.04	0.2	0.4	Ti Tl Tm	0.2	0.005 0.02 0.01	0.2 7 0.02	10 14 0.04
Hg Ho I In	1 0.2	0.06 0.01 0.01	0.01 0.0003 0.0005 0.0002	0.02 0.0006 0.003	U V W	3 0.3	0.02 0.004 0.05	0.002 0.0003 0.003	0.01 0.2 0.005
Ir K Kr	0.1	0.01 0.03 0.003 (0.001)	0.0002 0.002 0.03 (0.01)	0.0007 0.0004 0.06	xe Y Yb Zn	0.7 1	(0.004) 0.007 0.05 0.01	(0.1) 0.02 0.006 0.05	0.03 0.01 0.2
La Li Lu	0.4 1 ⁵)	0.01 0.0006 0.01	0.003 0.005 0.0001	0.006	Zr	0.4	0.01	1	2
Mg Mn Mo N	2 0.3 2	0.003 0.005 0.03 (0.0001)	0.02 0.0001 0.2	4 0.0002 0.5					
Na	15); 10	`0.002 ′	0.003	0.006					

Footnotes to Table 3

1) 0.G. Koch and G.H. Morrison 2 & 3) Assumed sample consumption 1 ml (2), 0.1 ml (3) 4) Values in paranthesis in μg 5) Indirect determination after precipitation with trace collect

(a) References 2, 89-106); (b) Reference 107 ; (c) References 2,108-111; (d) References 2, 112

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Table 4. L_Q values of some analytical methods ^{1,2}) in µg ml⁻¹

Element	Direct current (3)	Polarography Linear sweep & cathode ray	Pulse	Inverse Voltam- metry (17)	Ion-selective electrode potentiometry (4)	Footnotes to Table 4
Ag Al As Au B	0.1 0.1 0.5	0.005 ⁶⁾ 0.02	0.2 0.0001 0.004 0.005	0.00001 ⁵⁾ 0.002 ⁷⁾ 0.002 ⁸⁾ 0.001 ⁵⁾	0.02 * * 1 ⁹)	 Compiled by P.D.Lafleur Assumed sample consumption of 10 ml Classical polarography using the dropping mercury electrode Values given are for
Ba Bi Br Ca	0.5	0.05 0.05 ¹⁰)	0.005 0.0001 0.04	0.00001	0.8 0.4 0.5 0.03	direct measurements, elements marked with an asterisk can be determ. by indirect methods but limits have not been established 5) Bare glassy carbon elec-
Ca C1 Co Cr	0.2	0.02 1 0.05 0.1 0.02	0.002 0.0001 0.003 0.02	0.0001 ¹²⁾	0.03	 trode of epoxide-impre- gnated graphite 6) Solochrome Violet RS complex 7) Adsorption concentra- tion of complex on car-
F Fe H(H ₃ 0+	0.1 ')	0.005 ⁶⁾	0.002	0.0002 ¹³⁾	0.01 0.02 0.3 1×10^{-9} 2	bon paste electrode prior to oxidation 8) Au or Cu thin-film car- bon electrode 9) After conversion to BF ₄
I In K Li	10 1	0.05 ¹⁰⁾	0.0001 0.002	0.00002	0.1 0.8 0.05	 10) As iodate 11) Normal anodic stripping voltammetry, if not in- dicated by footnotes; average plating time 10 min
Mg Mn Mo Na	0.2 5.0	0.1	0.04 0.01 0.02		0.5 * 0.01	 12) Cathodic stripping of oxide on Pt electrode 13) Indirect method involv- ing chemical exchange with bismuth-EDTA com- plex
Ni O Pb	0.1 0.4	0.1 0.02	0.003	0.02 ¹²⁾ 0.00002	0.005 ¹⁴) 0.03	 14) Dissolved oxygen; but determination by a gal- vanic cell is to be preferred 15) Cathodic stripping from
s Sb Se Sn	0,5 0.2	0.05 0.2 0.05	0.004 0.00002 0.003	0.00004 215) 0.00004	*	 a hanging mercury drop electrode 16) Catalytic wave with nitrate 17) Average plating time 10 min.
Te Ti Tl U	1 1 0.1 ¹⁶⁾	0.02 0.05 0.01 ¹⁶⁾	0.008 0.01 0.01	0.00002		
V Zn Zr N(NH3,	0.5 2	0.1 0.05	0.003 0.002	0.002 ⁷⁾ 0.00003	0.1	
NH4,NC	$(\bar{3})$					

UHF-excitation sources like a microwave induced plasma (MIP) and capacitively-coupled micro-wave plasma (CMP) are less universal and are associated with more elemental cross-interferences. This is the reason that they have not yet been sufficiently investigated to compile their limits of applicability.

(b) Flame spectrometry. The fuel:oxidant gas combination with the best L $_{\mathsf{O}}$ value was chosen for each element.

6. X-ray fluorescence spectrometry (XRF) Table 3).

Only wavelength dispersive techniques will be considered. The L_0 values have been calculated for a sample diameter (in general on a paper filter or mylar foil as sample support) of 30-34 mm with a surface of 7-9 cm² assuming a sample consumption of 1 ml with respect to the solution technique, which only will be considered in this report.

7. Spark-source mass spectrography (Table 3) To calculate Lq it is assumed that 5×10^{11} singly charged ions are necessary to achieve the photographic limit of detection. The values calculated were corrected for the relative abundance of the principal isotope and further multiplied by 10 to take into account losses of substance during the measurement (a factor of 2), and for converting the detection limit into the determination limit (a factor of 5) and assuming a solution consumption of 0.1 ml. Solid-state mass spectrography will not be considered, because it is less sensitive.

8. Neutron activation (Table 3).

Also in this context the data are only given for solution techniques, assuming a sample amount of 0.1 ml. Non-destructive excitation of a solid sample will in each case lead to worse limits of determination. The values listed are based on the following assumptions using the mode of decay (γ or β) that will produce the best L₀ : viz. a thermal neutron flux of 10^{12} n cm⁻² s⁻¹, an irradiation time of 10 h, measurements without delay and loss of substance, i.e. without chemical separation, and with chemical separation with a delay of 30 min and a 50 % chemical yield and a detectable counting rate of 120 cpm for B-radiation and 300 cmp for γ -radiation.

9. Electrochemical methods (Table 4)

Among the methods treated in this survey, inverse (stripping) voltammetry is the only method that includes an preconcentration procedure, in the form of the plating (deposition) step. Therefore, in stripping voltammetry the sensitivity and L_Q are directly proportional to the plating time, which, depending on the time available for analysis, could be from less than 1 min to more than 30 min.

This should be considered when comparing the L_0 values for stripping voltammetry with those of the other methods. Mainly the anodic stripping technique is used. Exceptions are the cathodic stripping voltammetric determinations of Co and Se, the conditions of which are indicated by footnotes.

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